

MOSFET - Power, Dual N-Channel 100 V, 26 mΩ, 28 A NVMJD027N10MCL

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free, Beryllium Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	28	Α
Current R _{θJC} (Note 1)		T _C = 100°C		20	
Power Dissipation	State	T _C = 25°C	P_{D}	46	W
R _{θJC} (Note 1)		T _C = 100°C		23	
Continuous Drain		T _A = 25°C	I _D	7.4	Α
Current R _{0JA} (Notes 1, 2)	Steady State	T _A = 100°C		5.2	
Power Dissipation		T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1, 2)		T _A = 100°C	1	1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	115	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	35	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.3 A)			E _{AS}	291	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

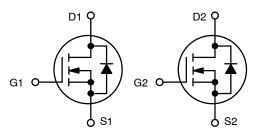
THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	3.29	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48	

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

1

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
100 V	26 mΩ @ 10 V	28 A

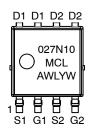


DUAL N-CHANNEL

MARKING DIAGRAM



LFPAK8 CASE 760AF



027N10MCL = Specific Device Code

A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

ORDERING INFORMATION

Device	Package	Shipping†
NVMJD027N10MCLTWG		3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{2.} Surface-mounted on FR4 board using 1 in² pad size, 1 oz. Cu pad.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				54.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 100 V$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 38 μΑ	1	1.5	3	٧
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.91		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _[_O = 7 A		21.8	26	mΩ
Forward Transconductance	9 _{FS}	$V_{DS} = 5 \text{ V}, I_{D}$	= 7 A		24.6		S
CHARGES & CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 50 V			697		pF
Output Capacitance	C _{OSS}				272		1
Reverse Transfer Capacitance	C _{RSS}				4		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 80 V, I _D = 7 A			4.8		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 80 V, I _D = 7 A			9.9		nC
Threshold Gate Charge	Q _{G(TH)}				0.6		1
Gate-to-Source Charge	Q _{GS}				1.8		1
Gate-to-Drain Charge	Q_{GD}				1.4		1
Plateau Voltage	V_{GP}				2.7		V
SWITCHING CHARACTERISTICS (Note 3	3)						
Turn-On Delay Time	t _{d(ON)}				7.1		ns
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 80 V, I_{D} = 7 A, R_{G} = 6 Ω			2.3		
Turn-Off Delay Time	t _{d(OFF)}				16.4		
Fall Time	t _f				3.4		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V_{SD}	$v_{GS} = 0 v$,	T _J = 25°C		0.85	1.2	٧
			T _J = 125°C		0.7		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 7 \text{ A}$			29		ns
Reverse Recovery Charge	Q _{RR}				20		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS

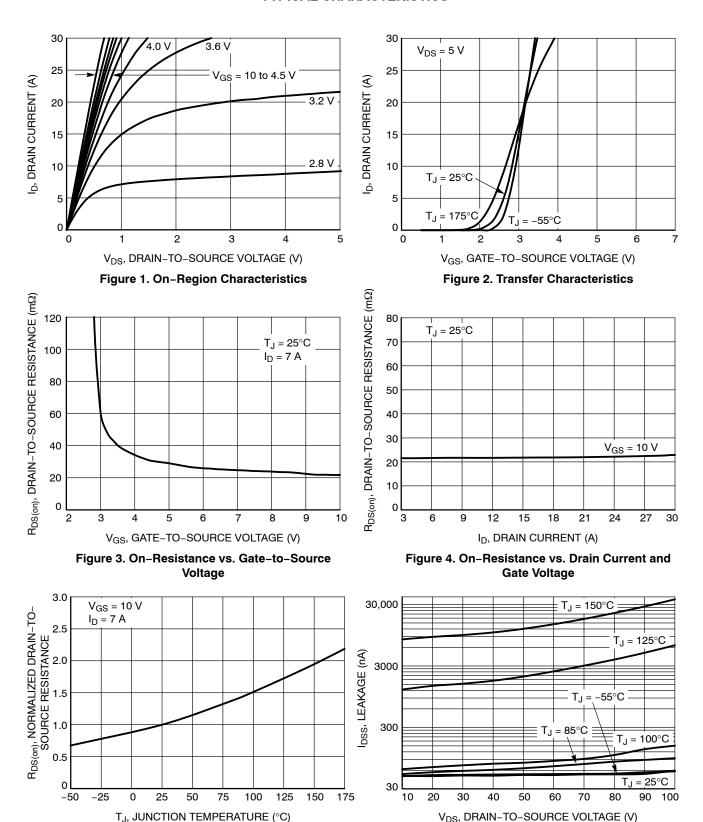


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS

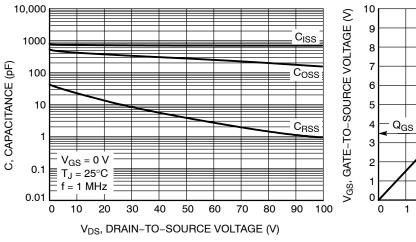


Figure 7. Capacitance Variation

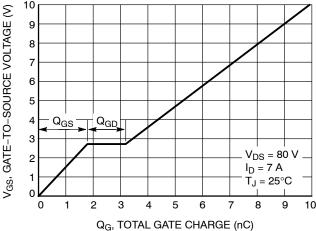


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

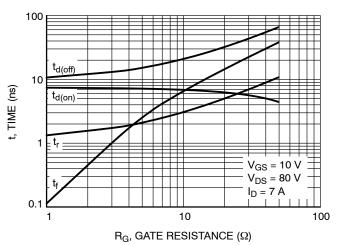


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

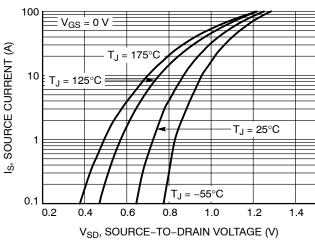


Figure 10. Diode Forward Voltage vs. Current

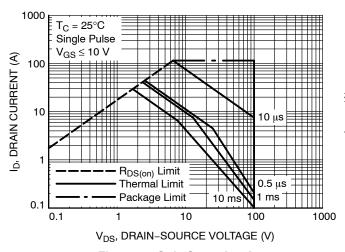


Figure 11. Safe Operating Area

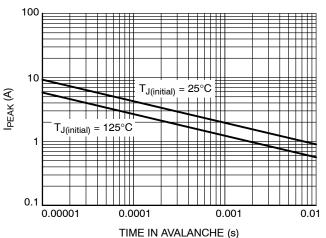


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

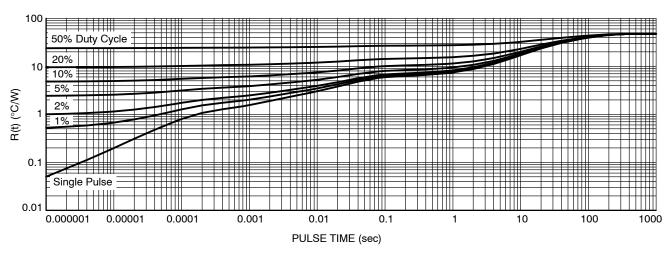
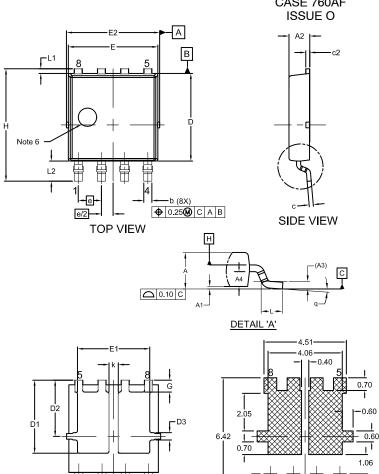


Figure 13. Thermal Characteristics

PACKAGE DIMENSIONS

LFPAK8 5.15x6.15CASE 760AF



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

MILLIMETERS					
DIM	MIN	NOM	MAX		
Α	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
A3	().25 REF	=		
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4.70	4.80	4.90		
D1	3.80	4.00	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
Е	4.80	4.90	5.00		
E1	3.90	4.00	4.10		
E2	5.00	5.15	5.30		
е	1	1.270 BSC			
e/2	0.635 BSC				
G	0.55	0.65	0.75		
I	6.00	6.15	6.30		
k	0.40	0.50	0.60		
L	0.45	0.65	0.85		
L1	0.15	0.25	0.35		
L2	0.90	1.10	1.30		
q	0°	4°	8°		

RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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